WHAT IS CLAIMED IS:

1. A semiconductor package comprising:

a substrate having a top surface and a bottom surface, the top surface including a plurality of substrate pads;

a semiconductor chip mounted on the substrate, the semiconductor chip having an active surface, a back surface, and a peripheral surface, the active surface including a plurality of chip pads;

a peripheral sealing portion formed along the peripheral surface of the semiconductor chip; and

a plurality of pattern leads providing electrical connections between chip pads and substrate pads, the pattern leads extending along an inclined surface of the peripheral sealing portion.

- A semiconductor package according to claim 1, further comprising:
 an encapsulant covering the semiconductor chip, the peripheral sealing
 portion, the substrate pads and the pattern leads.
- A semiconductor package according to claim 1, wherein:
 the peripheral sealing portion covers a peripheral portion of the active

surface.

- 4. A semiconductor package according to claim 2, further comprising: external connection terminals formed on the substrate, the external connection terminals being electrically connected to the substrate pads.
- 5. A semiconductor package according to claim 4, wherein:

 the external connection terminals are arranged on the bottom surface of
 the substrate and are selected from a group consisting of solder balls, solder
 bumps, microsprings and connecting pins.
- A semiconductor package according to claim 4, wherein:
 the external connection terminals are arranged on the top surface of the substrate.
- 7. A semiconductor package according to claim 1, wherein:

 the inclined surface of the peripheral sealing portion forms an angle of
 between about 30 and 75 degrees relative to the top surface of the substrate.
- 8. A semiconductor package according to claim 1, wherein:

the peripheral sealing portion includes an insulating composition selected from a group consisting of photo solder resists and plastic resins.

9. A semiconductor package comprising:

a substrate having a top surface and a bottom surface, the top surface including a plurality of substrate pads;

a semiconductor chip mounted on the substrate, the semiconductor chip having an active surface, a back surface, and a peripheral surface, the active surface including a plurality of chip pads;

a first peripheral sealing portion formed along the peripheral surface of the semiconductor chip;

a plurality of first pattern leads providing electrical connections between a first group of chip pads and a first group of substrate pads, the first pattern leads extending along an inclined surface of the first peripheral sealing portion;

a second peripheral sealing portion formed along the first peripheral sealing portion and the first pattern leads; and

a plurality of second pattern leads providing electrical connections between a second group of chip pads and a second group of substrate pads, the second pattern leads extending along an inclined surface of the second

peripheral sealing portion.

10. A semiconductor package according to claim 9, wherein:

a second pattern lead extends across a first pattern lead, electrical connection between the second pattern lead and the first pattern lead being prevented by an interposed portion of the second peripheral sealing portion.

- 11. A semiconductor package according to claim 9, wherein:
- the first group of chip pads is completely separate from the second group of chip pads.
- 12. A semiconductor package according to claim 9, wherein:

at least one chip pad is included in both the first group of chip pads and the second group of chip pads.

13. A semiconductor package according to claim 9, further comprising:

an encapsulant covering the semiconductor chip, the first peripheral sealing portion, the substrate pads, the first pattern leads, the second peripheral sealing portion and the second pattern leads.

14. A semiconductor package according to claim 9, wherein:

the first peripheral sealing portion covers a first peripheral portion of the active surface; and

the second peripheral sealing portion covers a second peripheral portion of the active surface.

- 15. A semiconductor package according to claim 9, further comprising: external connection terminals formed on the substrate, the external connection terminals being electrically connected to the substrate pads.
- 16. A semiconductor package according to claim 15, wherein:

the external connection terminals are arranged on the bottom surface of the substrate and are selected from a group consisting of solder balls, solder bumps, microsprings and connecting pins.

17. A semiconductor package according to claim 15, wherein:

the external connection terminals are arranged on the top surface of the substrate.

18. A semiconductor package according to claim 9, wherein:

the inclined surface of the first peripheral sealing portion forms an angle of between about 30 and 75 degrees relative to the top surface of the substrate; and

the inclined surface of the second peripheral sealing portion forms an angle of between about 30 and 75 degrees relative to the top surface of the substrate.

19. A semiconductor package according to claim 9, wherein:

the first and second peripheral sealing portions include an insulating composition selected from a group consisting of photo solder resists and plastic resins.

20. A method for manufacturing a semiconductor package comprising:

mounting a semiconductor chip on a substrate, the semiconductor chip
having a plurality of chip pads on an active surface and the substrate having a
plurality of substrate pads on a top surface;

forming a first peripheral sealing portion, the first peripheral sealing portion enclosing a peripheral surface of the semiconductor chip and having an inclined surface;

forming first pattern leads to establish electrical connections between a

first group of the chip pads and a corresponding first group of the substrate pads, the first pattern leads being formed on the inclined surface of the first peripheral sealing portion.